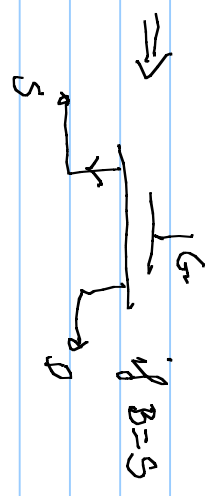
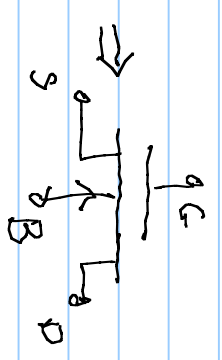
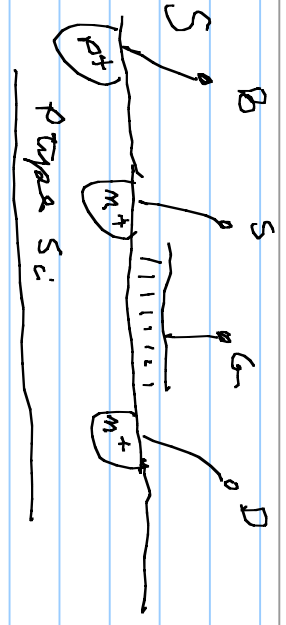


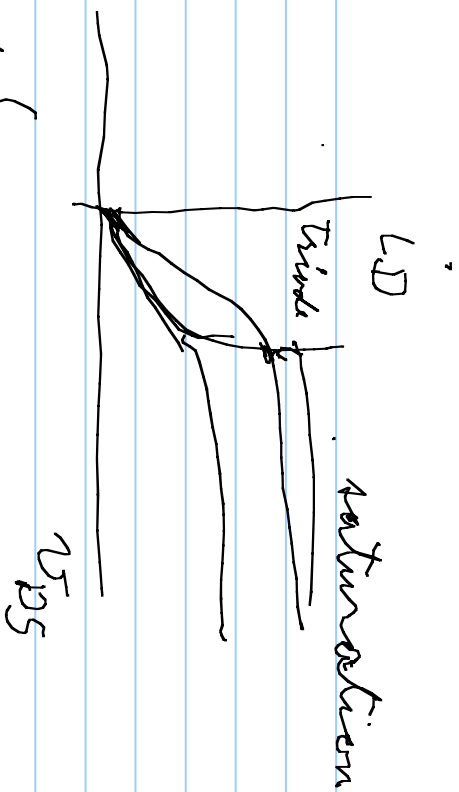
EE 303H
09/09/14

side view of NMOS

P. 233



for eqn. see
Ch. 5.1, p. 249



Eq. in saturation

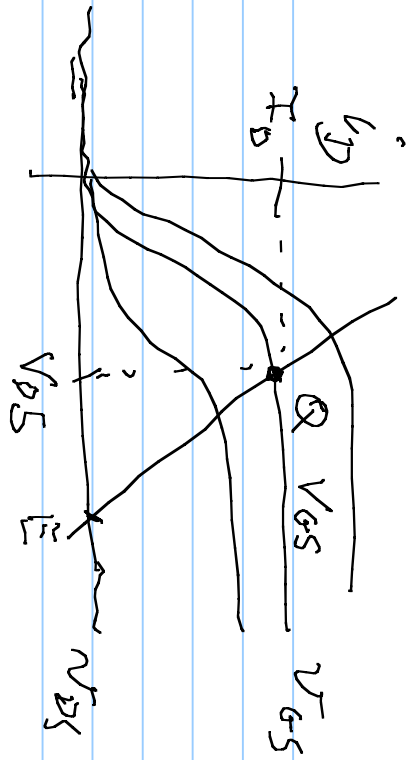
$$v_{DS} \geq v_{GS} - V_{T0}$$

$$i_D = \frac{k_p}{2} \frac{w}{L} (v_{GS} - V_{T0})^2 (1 + \lambda v_{DS})$$

$$v_{GS} > V_{T0} \left\{ \begin{array}{l} i_D = \frac{k_p}{2} \frac{w}{L} \{ \lambda (v_{GS} - V_{T0}) v_{DS} - v_{DS}^2 \} (1 + \lambda v_{DS}) \end{array} \right.$$

if $v_{DS} \leq v_{GS} - V_{T0}$

if $v_{GS} \leq V_{T0}$ then $i_D = 0$ turned off



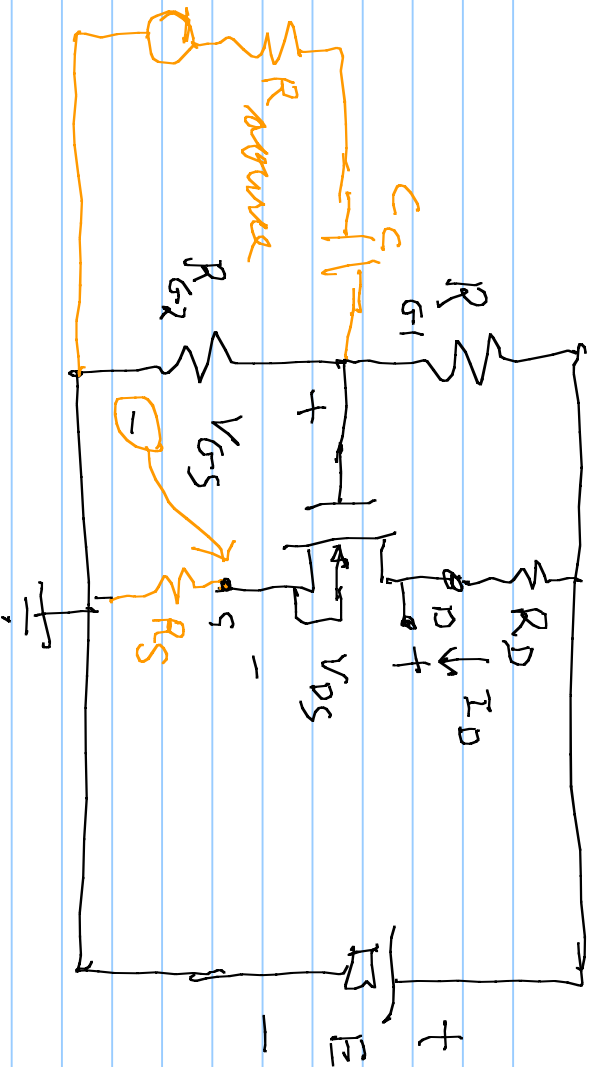
$$Y = X + v$$

Actual bias signal

$$V_D = I_D + v_a, \quad V_{DS} = V_{DS} + v_a$$

bias circuit, at 5.6, p. 253

Fig. 5.31, p. 274



design for a given Q pt.

choose large R_{G1} and design load source

$$\frac{R_{G2}/R_{G1}}{1 + R_{G2}/R_{G1}} = \frac{E}{V_{GS}}$$

$$V_{GS} = \frac{R_{G2}}{R_{G1} + R_{G2}} E$$

$$V_{DS} = E - R_D I_D$$

Given Q pt $\Rightarrow I_D, V_{DS}$

$$R_D \Rightarrow \frac{E - V_{DS}}{I_D} = R_D$$

Other Transistor Behaviors use Taylor series for i_D

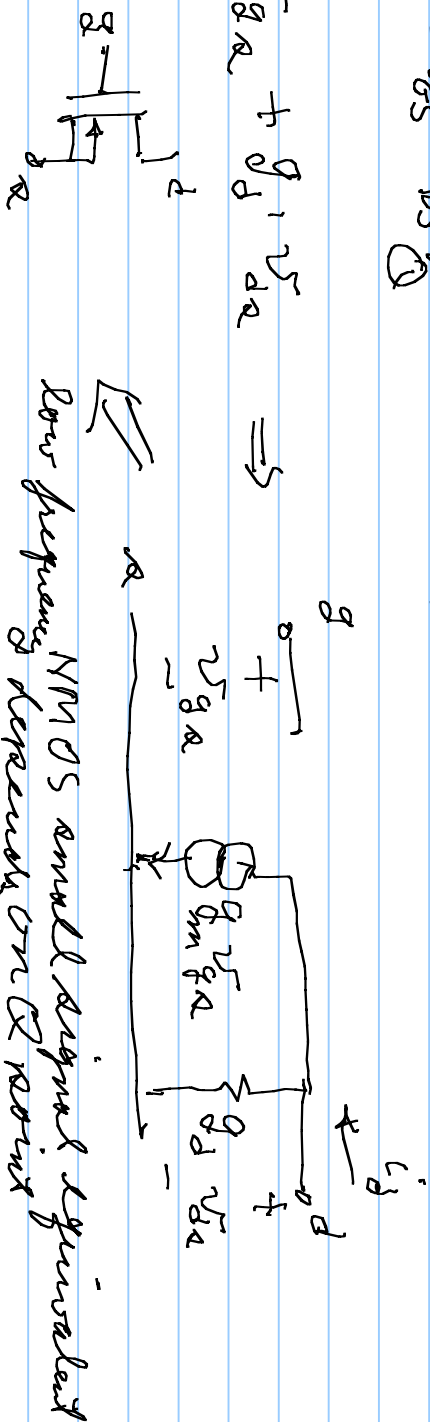
vs. v_{GS}, v_{DS}

$$i_D(v_{GS}, v_{DS}) = i_D(V_{GS}, V_{DS}) + \frac{\partial i_D}{\partial v_{GS}} \Big|_{(v_{GS} - V_{GS})} + \frac{\partial i_D}{\partial v_{DS}} \Big|_{(v_{DS} - V_{DS})}$$

drop for small signal

$$\left\{ \begin{array}{l} + \frac{\partial^2 i_D}{\partial v_{GS} \partial v_{DS}} \end{array} \right\} (v_{GS} - V_{GS})(v_{DS} - V_{DS}) + \dots$$

$$\Rightarrow i_D = g_m v_{gA} + g_D v_{dA}$$



Now frequency dependent dependent on Q point

$$q_d = \frac{\partial \Pi_D}{\partial v_{DS}} \Big|_Q \quad \text{in saturation}$$

$$= \frac{\partial \left[\frac{k_p \mu_n}{2} (v_{GS} - V_{T0})^2 (1 + \lambda v_{DS}) \right]}{\partial v_{DS}} \Big|_Q = \lambda \frac{k_p \mu_n}{2} (v_{GS} - V_{T0})^2 \Big|_Q$$

$$\approx \lambda \cdot I_D \Big|_Q = \lambda I_D$$

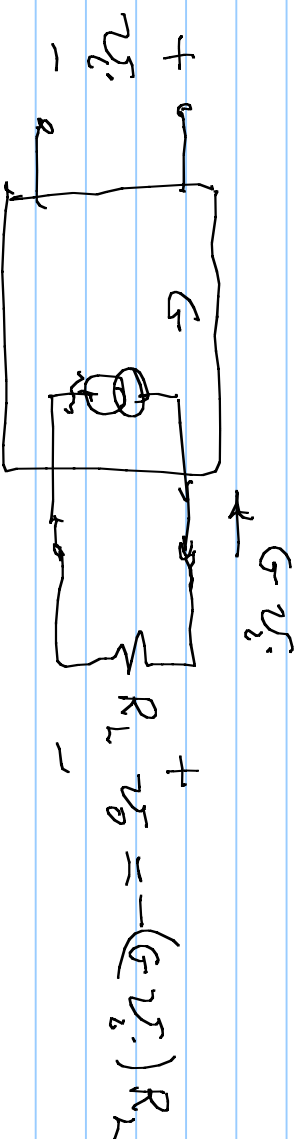
Q

$$q_{nm} = \frac{\partial I_D}{\partial v_{GS}} \Big|_{\text{in saturation}}$$

$$= \frac{\partial \left[\frac{k_p \mu_n}{2} (v_{GS} - V_{T0})^2 (1 + \lambda v_{DS}) \right]}{\partial v_{GS}} \Big|_Q = \lambda \cdot \frac{k_p \mu_n}{2} (v_{GS} - V_{T0}) (1 + \lambda v_{DS}) \Big|_Q$$

$$= \frac{2 I_D}{V_{GS} - V_{T0}}$$

as a theoretical case:



gain $\frac{v_o}{v_i} = -G R_L \Rightarrow -g_m R_L$ for transistors

\therefore if $g_m \approx 2 \times 10^{-3} = 2 \text{ mS}$ then $R_L = 10 \text{ k}\Omega$ gives $\frac{v_o}{v_i} = -20$ as gain